



Fakultät Informatik Institut für Angewandte Informatik

## Improved Simple Simulation Models for Semiconductor Wafer Factories

**Oliver Rose** 



#### Research overview



Measurement & Analysis

# **High-level Production Control** Dispatching Simulationbased **Scheduling Simulation** Model **Complex Production System**

Slide 2

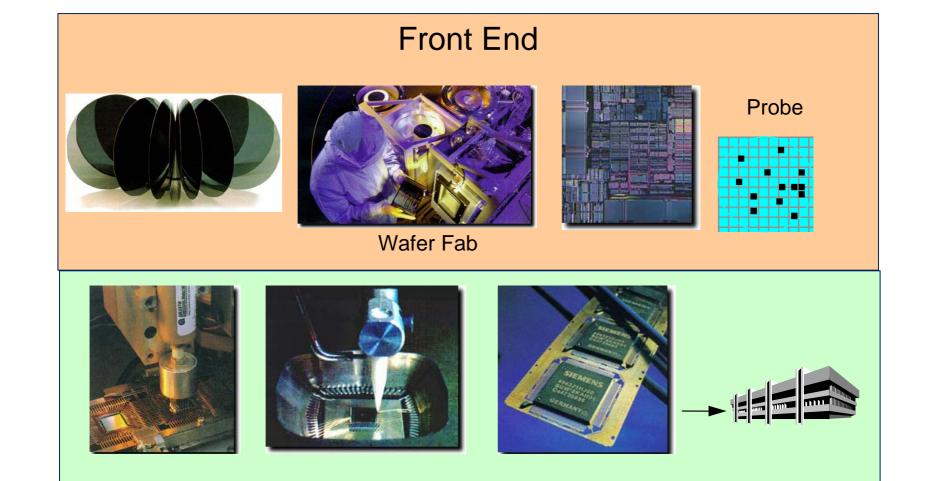
**Automation of Data Transfer** 



## **Semiconductor manufacturing**



Test



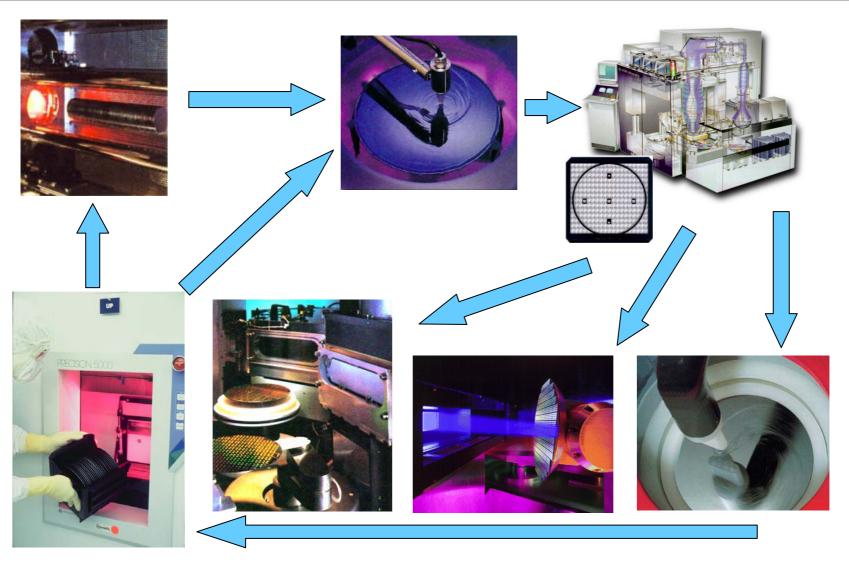
**Back End** 

Assembly



#### Flow of material





Fotos: Fullman-Kinetics, Varian, Sematech International



#### There are still humans involved!



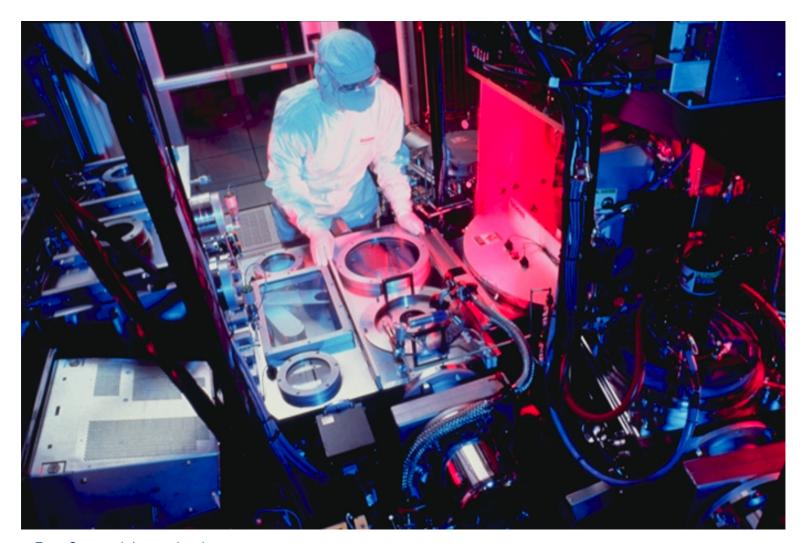


Foto: Sematech International



## How do the tools usually look like?







Fotos: Firma Varian



#### **Characteristics of wafer fabs**



- Large number of processing steps, typically several hundreds
- Large number of tools of different types: photo equipment, ovens, etching equipment, ion implanters, ...
- Wafer are build up in layers: reentrant flow of material, jobshop-like way of production
- Frequent machine breakdowns (typical availability: 70-90%)
- Auxiliary resources, e.g., reticles (photo masks)
- Batch tools with complex batching criteria
- Sequence dependent setups
- High level of automation
- Operators with different types of skills



#### **Control factors**



- Factory load
- Product mix
- Number of machines and operators
- Preventive maintenance policies
- Production planning & control policies:
  - scheduling vs. dispatching,
  - lot release vs. shop-floor control,
  - ...



## Operational modeling



- Model components
  - Tool set: type of tool, setups, breakdowns, ...
  - Secondary resources: worker, photo masks, ...
  - Products: lot sizes, arrival patterns, ...
  - Product recipes: lists of operations
  - Material flow control: lot release rules, dispatching rules
- Most tools seen as blackbox
  - Internal behavior of tool not modeled
  - Exception: cluster tools



#### Important operational questions



Slide 10

- Most appropriate dispatching rule
- Most appropriate lot release rule
- Output prediction
- Cycle time prediction
- Lateness prediction
- Forecast of short-term material flow problems
- Workarounds after random events (breakdown, operator unavailability, ...)
- Effect of product mix changes (surge analysis)
- Practical relevance of schedules (robustness, stability)

## No alternative to simulation as a decision support tool!



## Motivation for simple models



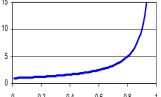
- Traditionally, only full detail models used for operational planning and control of semiconductor fabs
- Consequences:
  - Long run times of simulation experiments
  - Long run times of scheduling algorithms
  - Too complex to be included in enterprise models for SCM (Supply Chain Management)
- Need for simple fab models



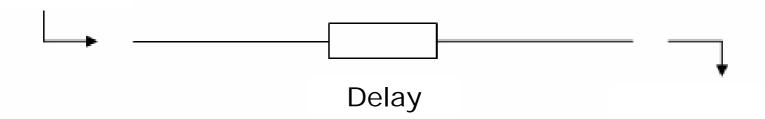
### Simple modeling approaches



- Requirements
  - Correct representation of characteristic curve (cycletime-over-utiliziation curve), i.e., typically
    1/(1-utilization) shape
  - Same cycle time distributions as for real fab
  - Mimic typical behavior of fab over time



- Very simple model: cycle time distribution
  - Does not depend on utilization
  - Has infinite capacity

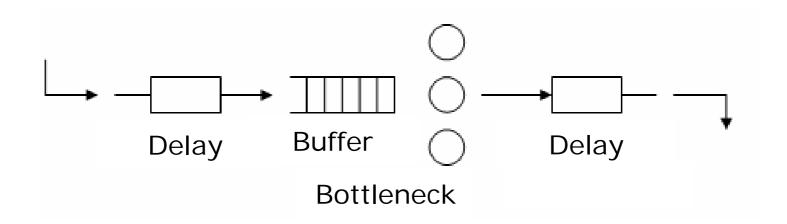




## Simple modeling approaches



- Simple queuing system
  - Behavior over time not appropriate
  - In general, shape of characteristic curve problematic

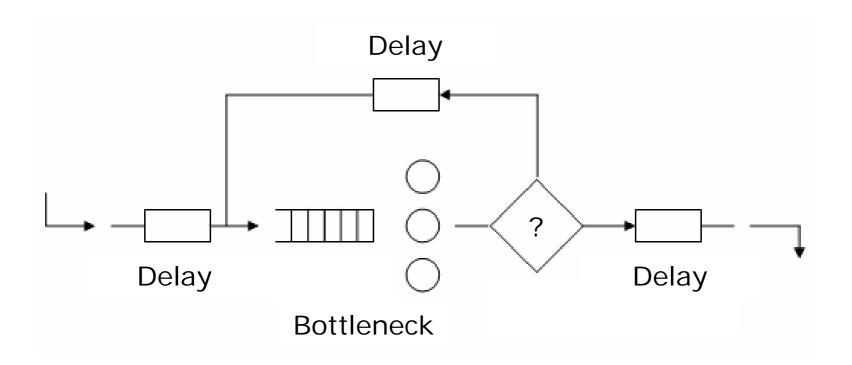




## Simple modeling approaches



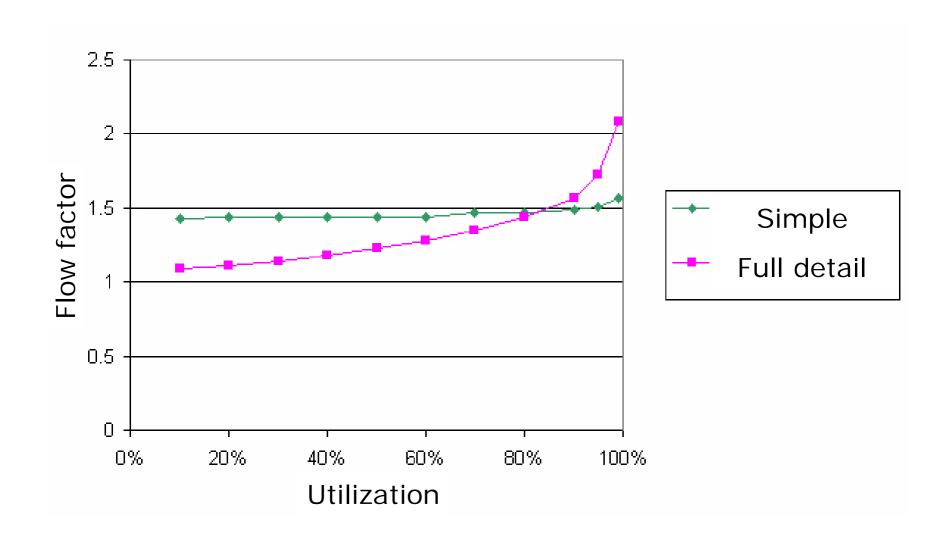
 Simple queuing system with loop (re-entrant flow of material)





#### **Characteristic curve**



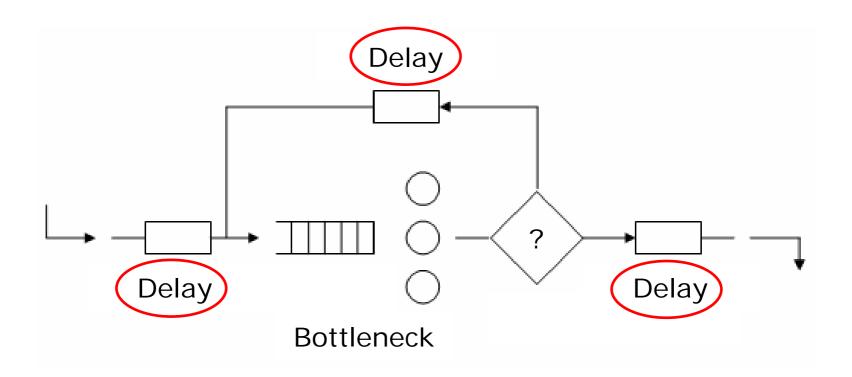




## Model improvement approach



## Make delays load dependent! But how to measure load?

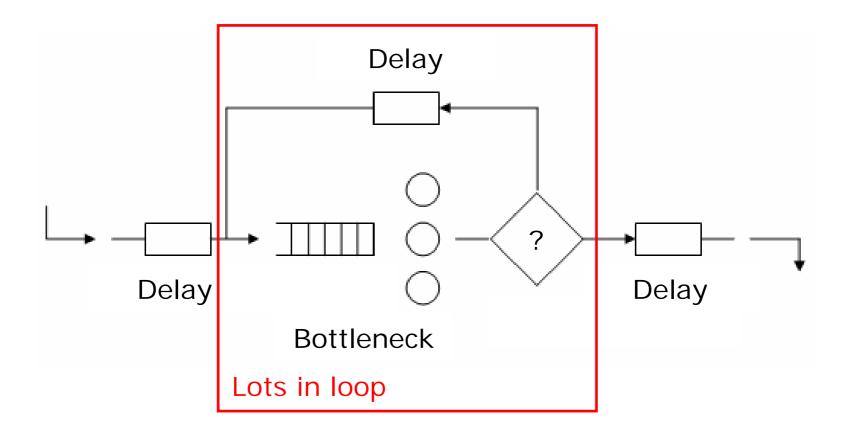




#### Load measurement



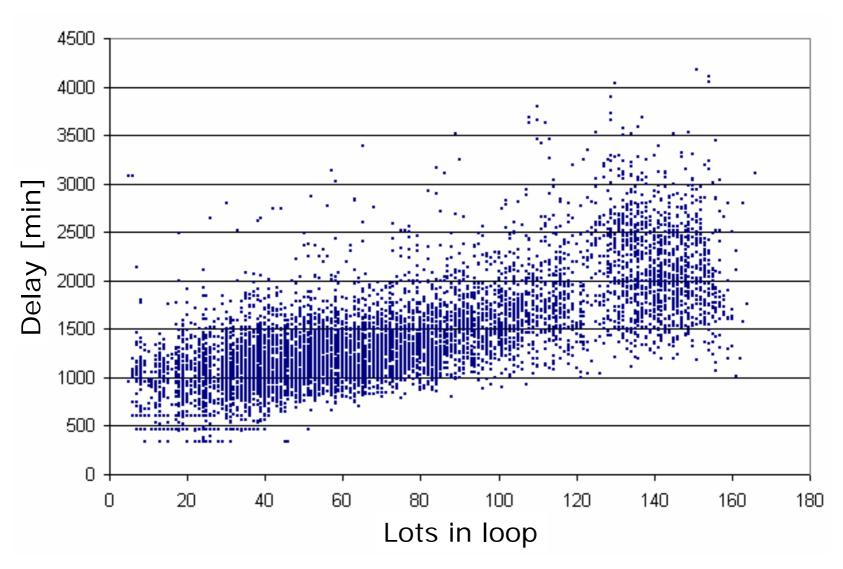
#### Simply count lots in bottleneck loop!





## Load-dependent "loop" delays

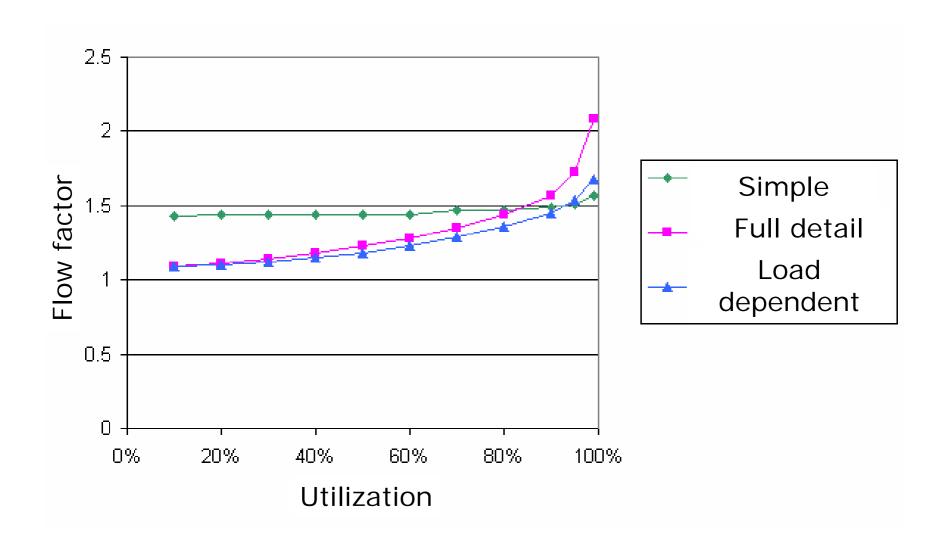






## Improvement of the char. curve

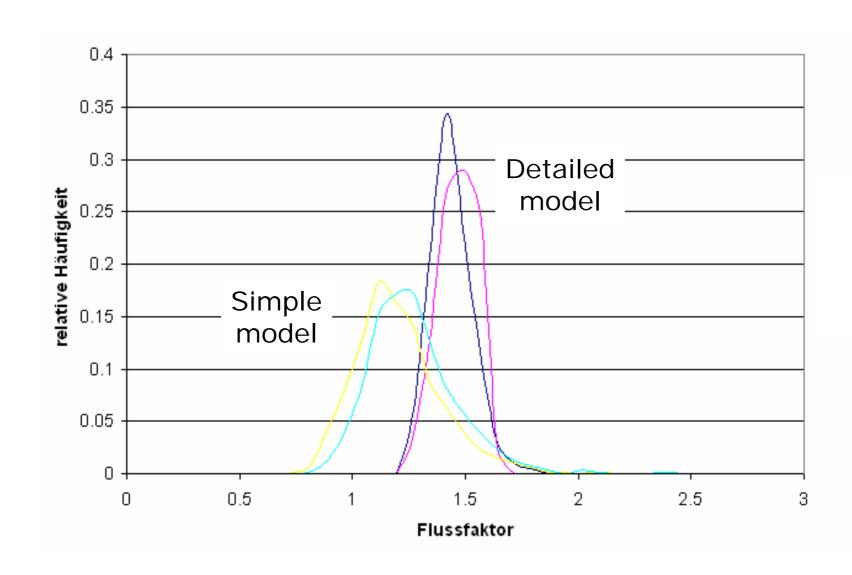






## Cycle time distributions



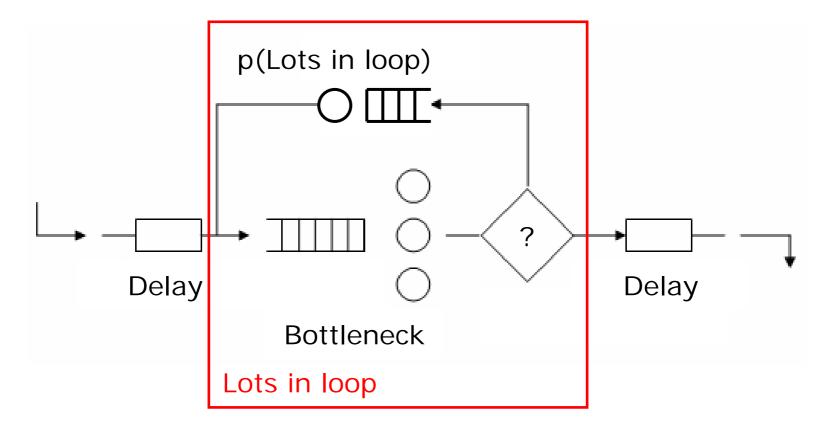




#### New approach



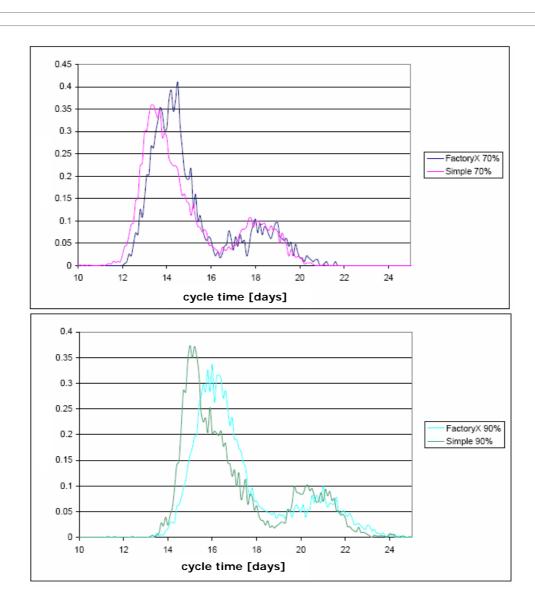
- Replace delay component by a single server component with load dependant service times
- Consequence: no more lot passing (overtaking)





## **Cycle time distributions**

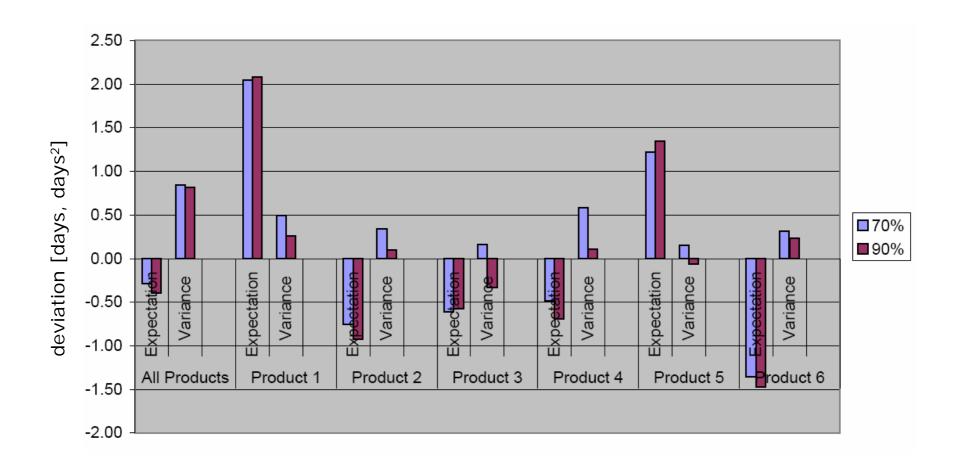






## Simple model deviations from full one







## Conclusions for simple model study



- Seems possible to have it all: mimic fab behavior + characteristic curve + cycle time distribution
- Simple models useful for analyzing and understanding complex production systems
- Not a tool for beginners
- Not appropriate for all problems
- Pitfall of oversimplification
- Simplification must not be the goal but only the method to reach the goal
- Keep the model as simple as possible but not simpler!



#### Outlook



- Models for real fabs too large and too complex:
  You don't see the forest for the trees!
- Difficulties to formulate all material flow constraints of real systems, but:
   Is it really necessary to consider all details?
- Evolution in semiconductor manufacturing towards "lights out" fab
  - no operators but fully automated
  - even more decisions to be made by production control
- Still a lot of work to do to find
  - Better (useful!!!) models
  - Faster planning procedures



#### Questions?



